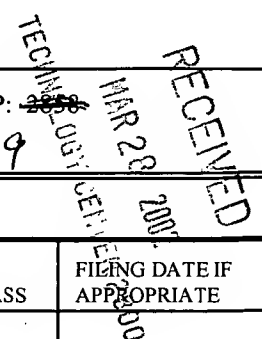
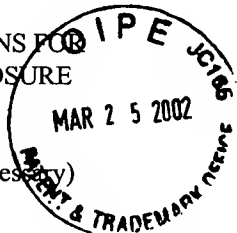


Page 1 of 2

FORM PTO-1449 (Modified) LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)	ATTY. DOCKET NO. KLR 1016.073	SERIAL NO.: 09//997,501
	APPLICANT: Hayden, et al.	
	FILING DATE November 19, 2001	GROUP: 2829



REFERENCE DESIGNATION
U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
E.P.K.	AA	6,118,287	Sep. 12, 2000	Boll, et al.	—	—	
E.P.K.	AB	6,091,256	Jul. 18, 2000	Long, et al.	—	—	
E.P.K.		6,046,599	Apr. 15, 1997	Long, et al.	—	—	
E.P.K.		5,621,333	Apr. 4, 2000	Long, et al.	—	—	
E.P.K.		5,507,652	Apr. 16, 1996	Wardwell	—	—	
E.P.K.		5,565,788	Oct. 15, 1996	Burr, et al.	—	—	
E.P.K.		5,506,515	Apr. 9, 1996	Godshalk, et al.	—	—	
E.P.K.		5,463,324	Oct. 31, 1995	Wardwell, et al.	—	—	
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E.P.K.		5,373,231	Dec. 13, 1994	Boll, et al.	—	—	
E.P.K.		5,289,117	Feb. 22, 1994	Van Loan, et al.	—	—	
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E.P.K.		4,810,981	Mar. 7, 1984	Herstein	—	—	
E.P.K.		4,764,723	Aug. 1988	Strid	—	—	
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E.P.K.		4,727,319	Feb. 23, 1988	Shahriary	—	—	
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E.P.K.		4,116,523	Sep. 26, 1978	Coberly, et al.	—	—	
E.P.K.		4,009,456	Feb. 22, 1977	Hopfer	—	—	
E.P.K.		3,849,728	Nov. 19, 1974	Evans	—	—	

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
E. 7K	BA	EPO 0 259 183 A2	09-03-88	EUROPE BE, CH, DE, ES, FR, GB, IT, LI, LU, NL, SE	—	—		
E. 7K	BB	Japan 1- 209380	1988	JAPAN MAR 25 2002 JAN 25 2002	—	—		
E. 7K	BC	605462 Japan	04-30-1984	JAPAN	—	—		
E. 7K	BD	59 4189 Japan	January 11, 1984	JAPAN	—	—		

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E. 7K	CA	Cascade Microtech, Inc.; WPH-700 Series Multi-contact High-Speed Integrated Circuit Probes; April 30, 1991.
E. 7K	CB	Cascade Microtech, Inc.; Special Purpose Probe 40/80 Gb/s High Performance Quadrant. prior to 11-19-00
E. 7K	CC	Cascade Microtech, Inc.; Application Note, Layout rules for WPH-900 series probes, 1996. (month unavailable)
E. 7K	CD	Maury Microwave Corp.; Transistor Test Fixture (TTF) Software, Software Application Packs, 20 Sept. 1982
E. 7K	CE	Maury Microwave Corp.; Transistor Test Fixture (TTF) Universal; MT 950 Series, 7 Oct. 1982.
E. 7K	CF	Maury Microwave Corp.; Transistor Test Fixture (TTF) Universal; MT 950 Series, May 1985.
E. 7K	CG	Inter-Continental Microwave; Microwave Semiconductor Chip Measurements using HP 8510B Tri-Calibration Technique. prior to 11-19-00
E. 7K	CH	Design Technique; Microstrip Microwave Test Fixtures, 1986. (month unavailable)
E. 7K	CI	Design Technique; Adjustable Test Fixtures, 1988. (month unavailable)
E. 7K	CJ	Microwave Journal, Microwave Products, Sept. 1988, pp. 297.
E. 7K	CK	Inter-Continental Microwave, Product Catalogue. prior to 11-19-00
E. 7K	CL	Japanese Utility Model Registration, Early Disclosure No. 59-4189, High Frequency Coaxial Connector, Chernoff Vilhauer McClung & Stenzel, Portland, OR; Jan. 11 1984
E. 7K	CM	Cascade Microtech, Introducing 0.1 percent MIC vector measurement; April 1989.
Examiner Signature	Ernest A. Kaden	
Date Considered	Feb. 6, 2003	

¹ Unique citation designation number. ² Applicant is to place a check mark here if English language translation is attached.

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